

MOS FIELD EFFECT TRANSISTORS

2SK2499, 2SK2499-Z

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

The 2SK2499 is N-Channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

· Low On-Resistance

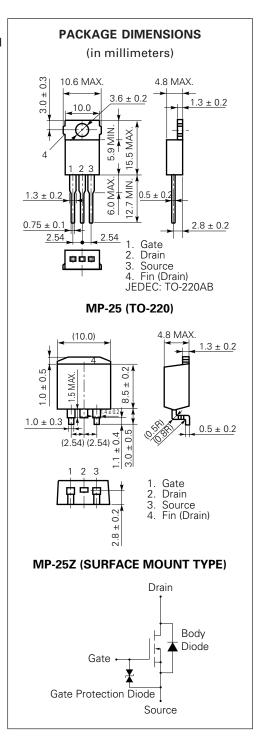
 $R_{DS(on)1} = 9 \text{ m}\Omega \text{ (VGS} = 10 \text{ V, ID} = 25 \text{ A)}$ $R_{DS(on)2} = 14 \text{ m}\Omega \text{ (VGS} = 4 \text{ V, ID} = 25 \text{ A)}$

- Low Ciss Ciss = 3 400 pF TYP.
- · High Avalanche Capability.
- · Built-in G-S Protection Diode

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

Drain to Source Voltage	VDSS	60	V
Gate to Source Voltage	Vgss	±20	V
Drain Current (DC)	ID(DC)	±50	Α
Drain Current (pulse)*	ID(pulse) ±200	Α
Total Power Dissipation ($T_c = 25$ °C)	P _{T1}	75	W
Total Power Dissipation (T _A = 25 °C)	P _{T2}	1.5	W
Channel Temperature	T_ch	150	°C
Storage Temperature	Tstg	-55 to +150	°C
Single Avalanche Current**	las	50	Α
Single Avalanche Energy**	Eas	250	mJ

- * PW 10 μ s, Duty Cycle 1 %
- ** Starting T_{ch} = 25 °C, R_G = 25 Ω , V_{GS} = 20 V \rightarrow 0



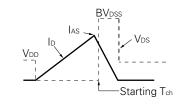


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

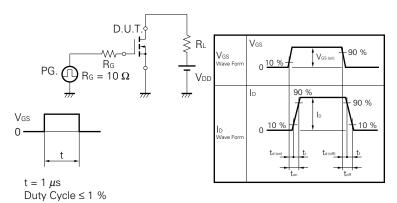
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Drain to Source On-State Resistance	RDS(on)1		7.3	9.0	mΩ	Vgs = 10 V, ID = 25 A
	RDS(on)2		11	14	mΩ	Vgs = 4 V, ID = 25 A
Gate to Source Cutoff Voltage	V _{GS(off)}	1.0	1.5	2.0	V	V _{DS} = 10 V, I _D = 1 mA
Forward Transfer Admittance	yfs	20	58		S	V _{DS} = 10 V, I _D = 25 A
Drain Leakage Current	IDSS			10	μΑ	V _{DS} = 60 V, V _{GS} = 0
Gate to Source Leakage Current	Igss			±10	μА	Vgs = ±20 V, Vps = 0
Input Capacitance	Ciss		3 400		рF	V _{DS} = 10 V
Output Capacitance	Coss		1 600		рF	Vgs = 0
Reverse Transfer Capacitance	Crss		770		рF	f = 1 MHz
Turn-On Delay Time	td(on)		55		ns	ID = 25 A
Rise Time	tr		360		ns	VGS(on) = 10 V
Turn-Off Delay Time	td(off)		480		ns	V _{DD} = 30 V
Fall Time	tf		360		ns	$R_G = 10 \Omega$
Total Gate Charge	Q _G		152		nC	ID = 50 A
Gate to Source Charge	Qgs		11		nC	V _{DD} = 48 V
Gate to Drain Charge	Q _{GD}		60		nC	Vgs = 10 V
Body Diode Forward Voltage	V _{F(S-D)}		0.92		V	IF = 50 A, VGS = 0
Reverse Recovery Time	trr		105		ns	IF = 50 A, VGS = 0
Reverse Recovery Charge	Qrr		265		nC	di/dt = 100 A/μs

Test Circuit 1 Avalanche Capability

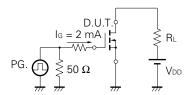
$V_{GS} = 20 \rightarrow 0 \text{ V}$ $V_{GS} = 20 \rightarrow 0 \text{ V}$



Test Circuit 2 Switching Time

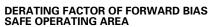


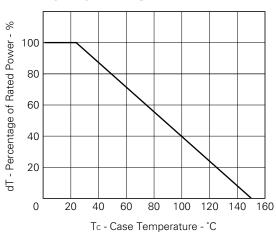
Test Circuit 3 Gate Charge



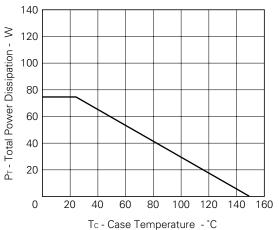
The application circuits and their parameters are for references only and are not intended for use in actual design-in's.

TYPICAL CHARACTERISTICS (TA = 25 °C)

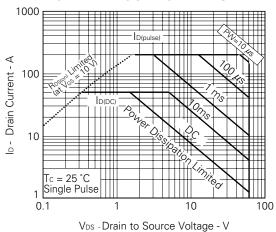




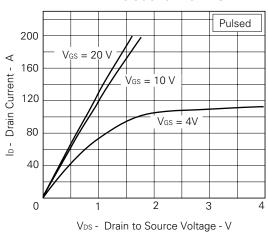
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



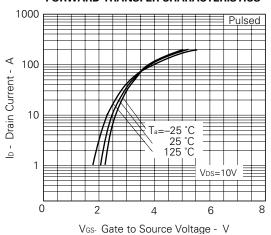
FORWARD BIAS SAFE OPERATING AREA



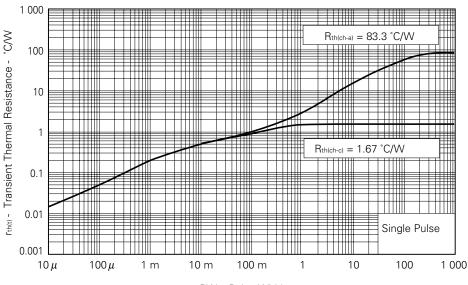
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



FORWARD TRANSFER CHARACTERISTICS

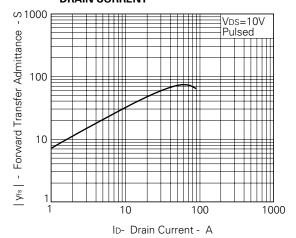


TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH

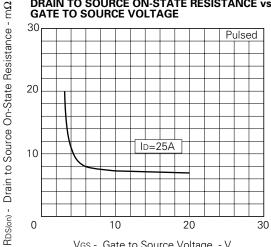


PW - Pulse Width - s

FORWARD TRANSFER ADMITTANCE vs. **DRAIN CURRENT**

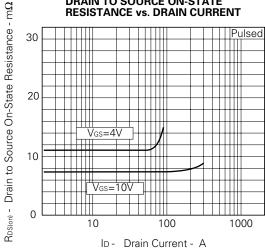


DRAIN TO SOURCE ON-STATE RESISTANCE vs. **GATE TO SOURCE VOLTAGE**

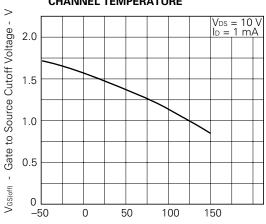


Vgs - Gate to Source Voltage - V

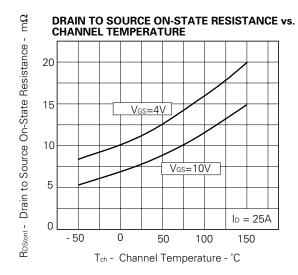
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT

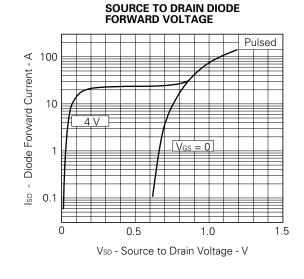


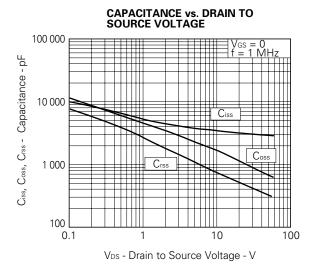
GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE

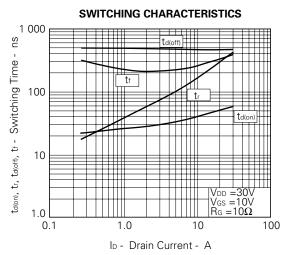


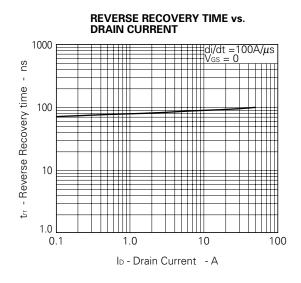
Tch - Channel Temperature - °C

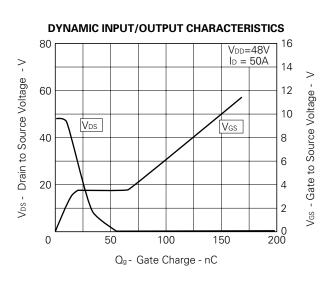




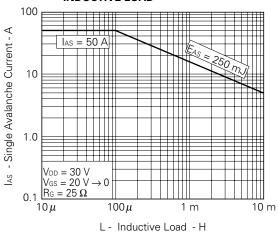




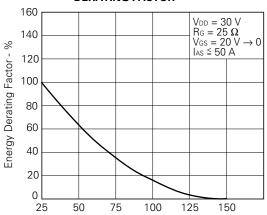




SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY DERATING FACTOR



Starting Tch - Starting Channel Temperature - °C

REFERENCE

Document Name	Document No.
NEC semiconductor device reliability/quality control system.	TEI-1202
Quality grade on NEC semiconductor devices.	IEI-1209
Semiconductor device mounting technology manual.	IEI-1207
Semiconductor device package manual.	IEI-1213
Guide to quality assurance for semiconductor devices.	MEI-1202
Semiconductor selection guide.	MF-1134
Power MOS FET features and application switching power supply.	TEA-1034
Application circuits using Power MOS FET.	TEA-1035
Safe operating area of Power MOS FET.	TEA-1037

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device is actually used, an additional protection circuit is externally required if a voltage exceeding

the rated voltage may be applied to this device.

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Anti-radioactive design is not implemented in this product.